Search Notes

Application/Control No.	Applicant(s)/Patent under Reexamination
10/562,935	NISHIO, AKIHIKO
Examiner	Art Unit

2618

Muhammad Akbar

SEARCHED					
Class	Subclass	Date	Examiner		

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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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	DATE	EXMR
Words searchs in EASt using class 455/69,67.11,522,423,502 and 375/265,285 and 370/208,342,329 (atattached search history)	11/27/2007	MA
IEEE/WIPO/EPO documents searches by using keywords feedback information,channel quality and reception quality in Base station	11/27/2007	MA
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